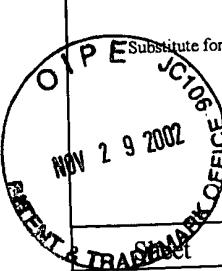


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Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE

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of

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Attorney Docket No.

108298631US

COMPLETE IF KNOWN

Application Number	10/033,340
Confirmation Number	7237
Filing Date	December 26, 2001
First Named Inventor	Suan Jeung Boon
Group Art Unit	2811
Examiner Name	Not yet assigned

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*EXAMINER INITIALS	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		NUMBER	Kind Code (if known)			
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<i>MH</i>	AB	5,841,193		Eichelberger	11/24/98	
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	AD					
	AE					
	AF					
	AG					

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	AI							
	AJ							
	AK							
	AL							

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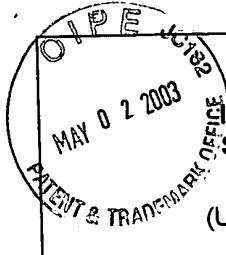
*EXAMINER INITIALS	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume/issue number(s), publisher, city and/or country where published.	T
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Application Number	10/033,340
Confirmation Number	7237
Filing Date	December 26, 2001
First Named Inventor	Boon Suan Jeung
Group Art Unit	2818
Examiner Name	Mai Huong C. Tran

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Attorney Docket No. 108298631US

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Sheet	2	of	2	Attorney Docket No.	108298631US
Application Number	10/033,340				
Confirmation Number	7237				
Filing Date	December 26, 2001				
First Named Inventor	Boon Suan Jeung				
Group Art Unit	2818				
Examiner Name	Mai Huong C. Tran				

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Examiner Initials*	Cite No.	U.S. Patent or Application		Name of Patentee or Inventor of Cited Document	Date of Publication or Filing Date of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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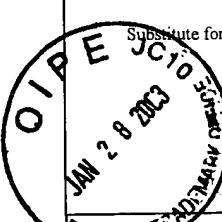
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MH		LAU, JOHN H. and SHI-WEI RICKY LEE, <i>Chip Scale Package (CSP). Design, Materials, Processes, Reliability, and Applications</i> , pp. 355, 487-488, ISBN 0-07-038304-9, February 1999, McGraw-Hill, New York.	

EXAMINER <i>Mai Huong C. Tran</i>	DATE CONSIDERED <i>05/03</i>
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Examiner Name	Not yet assigned

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